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|-----------------------------------|--|-------------------------|---|-------------|
| Notice of References Cited | | Application/Control No. | Applicant(s)/Patent Under Reexamination | |
| | | 10/078,750 | LAKHDAR BACHA, LUCAS | |
| Examiner | | Sean E. Conley | Art Unit | Page 1 of 1 |
| 1744 | | | | |

U.S. PATENT DOCUMENTS

| * | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|--|-----------------|-------------------|----------------|
| A | US-2003/0132279 | 07-2003 | Stemmle, Denis J. | 232/31 |
| B | US-6,818,177 | 11-2004 | Turcotte, Mark | 422/24 |
| C | US-2004/0022665 | 02-2004 | Lu, Michael Yuan | 422/1 |
| D | US-6,753,536 | 06-2004 | Humphreys et al. | 250/455.11 |
| E | US- | | | |
| F | US- | | | |
| G | US- | | | |
| H | US- | | | |
| I | US- | | | |
| J | US- | | | |
| K | US- | | | |
| L | US- | | | |
| M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|--|-----------------|---------|------|----------------|
| N | | | | | |
| O | | | | | |
| P | | | | | |
| Q | | | | | |
| R | | | | | |
| S | | | | | |
| T | | | | | |

NON-PATENT DOCUMENTS

| | | |
|---|---|--|
| * | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) | |
| U | | |
| V | | |
| W | | |
| X | | |

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